

MOSFET - Power, Single N-Channel, SO-8 FL 30 V, 69 A NTMFS4C06N

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- CPU Power Delivery
- DC-DC Converters

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

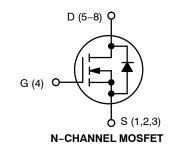
Parameter			Symbol	Value	Unit
Drain-to-Source Volta	ige		V_{DSS}	30	V
Gate-to-Source Volta	ge		V_{GS}	±20	V
Continuous Drain Current R _{0JA} (Note 1)	$T_{A} = 25^{\circ}C$ $T_{A} = 80^{\circ}C$		I _D	20.0 14.9	Α
Power Dissipation R _{0JA} (Note 1)		T _A = 25°C	P _D	2.55	W
Continuous Drain Current R _{θJA} ≤ 10 s (Note 1)		$T_A = 25$ °C $T_A = 80$ °C	I _D	31.6 23.7	Α
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T _A = 25°C	P _D	6.4	W
Continuous Drain Current R _{0JA} (Note 2)	State	$T_A = 25^{\circ}C$ $T_A = 80^{\circ}C$	Ι _D	11 8.2	Α
Power Dissipation R _{0JA} (Note 2)		T _A = 25°C	P _D	0.77	W
Continuous Drain Current R _{θJC} (Note 1)		$T_C = 25^{\circ}C$ $T_C = 80^{\circ}C$	I _D	69 52	Α
Power Dissipation R _{θJC} (Note 1)		T _C = 25°C	P _D	30.5	W
Pulsed Drain Current	T _A = 25°	°C, t _p = 10 μs	I_{DM}	476	Α
Operating Junction and Storage Temperature Range			T _J , T _{STG}	–55 to +150	°C
Source Current (Body Diode)			I _S	28	Α
Drain to Source DV/DT			dV/d _t	7.0	V/ns
Single Pulse Drain-to-Source Avalanche Energy ($T_J = 25^{\circ}C$, $V_{GS} = 10$ V, $I_L = 37$ A _{pk} , $L = 0.1$ mH, $R_{GS} = 25$ Ω) (Note 3)			E _{AS}	68	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

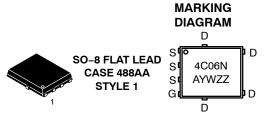
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface–mounted on FR4 board using the minimum recommended pad size. 3. Parts are 100% tested at $T_J = 25^{\circ}\text{C}$, $V_{GS} = 10 \text{ V}$, $I_L = 27 \text{ A}_{pk}$, EAS = 36 mJ.

1

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30 V	4.0 m Ω @ 10 V	69 A
30 V	6.0 mΩ @ 4.5 V	09 A





= Assembly Location

= Year = Work Week = Lot Traceabililty

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4C06NT1G	SO-8 FL (Pb-Free)	1500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	4.1	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	49	°C/W
Junction-to-Ambient - Steady State (Note 5)	$R_{ heta JA}$	162.3	*C/VV
Junction-to-Ambient – (t ≤ 10 s) (Note 4)	$R_{ heta JA}$	19.5	

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
OFF CHARACTERISTICS								
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D =	250 μΑ	30			V	
Drain-to-Source Breakdown Voltage (transient)	V _{(BR)DSSt}	$V_{GS} = 0 \text{ V, } I_{D(aval)} = 12.6 \text{ A,}$ $T_{case} = 25^{\circ}\text{C, } t_{transient} = 100 \text{ ns}$		34			V	
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				14.4		mV/°C	
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$			1.0		
		V _{DS} = 24 V	T _J = 125°C			10	μΑ	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS}$	= ±20 V			±100	nA	
ON CHARACTERISTICS (Note 6)								
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	250 μΑ	1.3		2.1	V	
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				3.8		mV/°C	
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		3.2	4.0	0	
		V _{GS} = 4.5 V	I _D = 25 A		4.8	6.0	mΩ	
Forward Transconductance	9 _{FS}	V _{DS} = 1.5 V, I _D	= 15 A		58		S	
Gate Resistance	R_{G}	T _A = 25°C		0.3	1.0	2.0	Ω	
CHARGES AND CAPACITANCES								
Input Capacitance	C _{ISS}				1683			
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V			841		pF	
Reverse Transfer Capacitance	C _{RSS}				40			
Capacitance Ratio	C _{RSS} /C _{ISS}	V _{GS} = 0 V, V _{DS} = 15	V, f = 1 MHz		0.023			
Total Gate Charge	Q _{G(TOT)}				11.6			
Threshold Gate Charge	Q _{G(TH)}				2.6		nC	
Gate-to-Source Charge	Q_{GS}	V _{GS} = 4.5 V, V _{DS} = 15	5 V; I _D = 30 A		4.7			
Gate-to-Drain Charge	Q_{GD}				4.0		1	
Gate Plateau Voltage	V_{GP}				3.1		V	
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V; I _D = 30 A			26		nC	
SWITCHING CHARACTERISTICS (Note 7)								
Turn-On Delay Time	t _{d(ON)}				10			
Rise Time	t _r	V_{GS} = 4.5 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			32			
Turn-Off Delay Time	t _{d(OFF)}				18		ns	
Fall Time	t _f				5.0		1	

^{6.} Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.
7. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

	<u> </u>				_		
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 7)						
Turn-On Delay Time	t _{d(ON)}				8.0		
Rise Time	t _r	V_{GS} = 10 V, V_{DS} = 15 V, I_D = 15 A, R_G = 3.0 Ω			28		ns
Turn-Off Delay Time	t _{d(OFF)}				24		
Fall Time	t _f	1			3.0		1
DRAIN-SOURCE DIODE CHARACTI	ERISTICS						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	T _J = 25°C		0.8	1.1	.,,
		$V_{GS} = 0 \text{ V},$ $I_{J} = 25^{\circ}\text{C}$ $I_{J} = 125^{\circ}\text{C}$		0.63		V	
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 30 \text{ A}$			34		
Charge Time	t _a				17		ns
Discharge Time	t _b				17		
Reverse Recovery Charge	Q_RR				22		nC

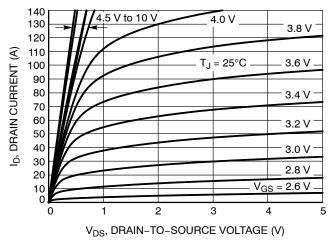
^{6.} Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

^{7.} Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

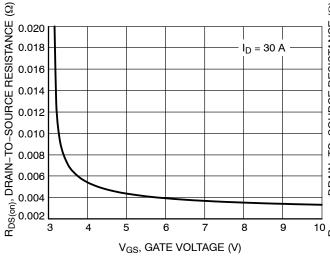
80



70 $V_{DS} = 5 V$ ID, DRAIN CURRENT (A) 60 50 40 30 $T_J = 25^{\circ}C$ 20 $T_J = 125^{\circ}C$ 10 $T_J = -55^{\circ}C$ 0 0.5 1.0 1.5 2.0 2.5 3.0 3.5 V_{GS}, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



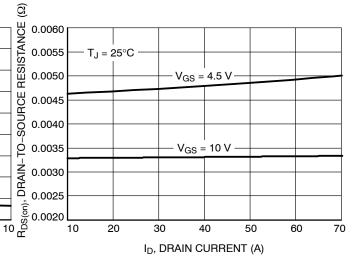
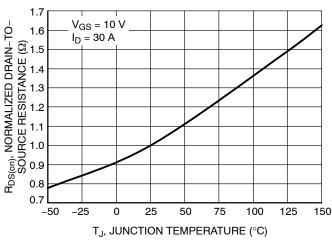


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



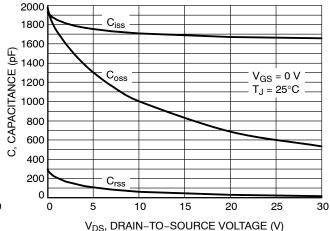


Figure 5. On–Resistance Variation with Temperature

Figure 6. Capacitance Variation

TYPICAL CHARACTERISTICS

1000

100

 $V_{GS} = 10 \text{ V}$ $V_{DD} = 15 V$ $I_D = 15 A$

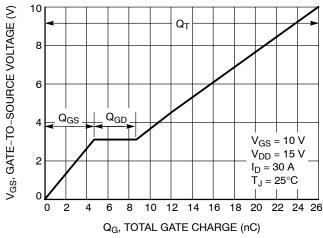


Figure 7. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

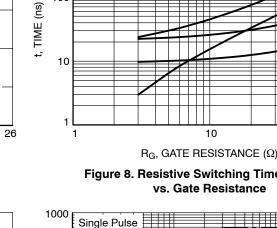


Figure 8. Resistive Switching Time Variation vs. Gate Resistance

10

100

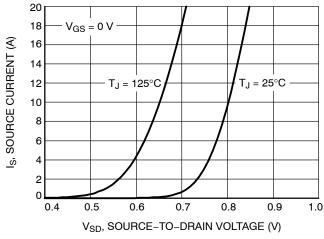


Figure 9. Diode Forward Voltage vs. Current

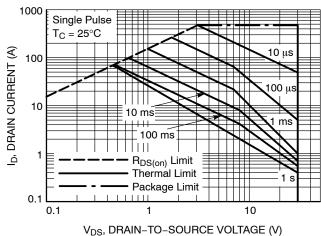


Figure 10. Maximum Rated Forward Biased Safe Operating Area

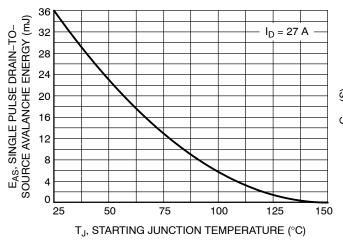


Figure 11. Maximum Avalanche Energy vs. **Starting Junction Temperature**

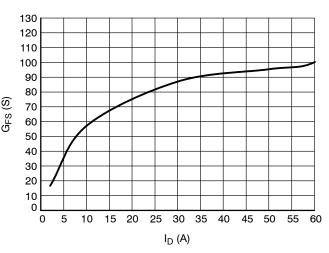


Figure 12. G_{FS} vs. I_D

TYPICAL CHARACTERISTICS

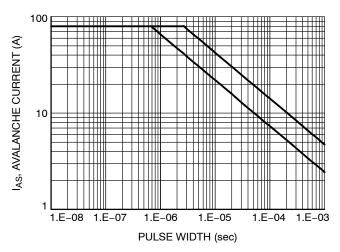


Figure 13. Avalanche Characteristics

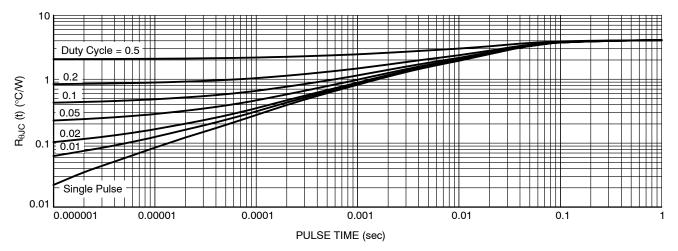


Figure 14. Thermal Response





0.10

SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA **ISSUE N**

DATE 25 JUN 2018

NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: MILLIMETER.
 3. DIMENSION D1 AND E1 DO NOT INCLUDE
- MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS				
DIM	MIN	MAX			
Α	0.90	1.00	1.10		
A1	0.00		0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D	5.00	5.15	5.30		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е		1.27 BSC)		
G	0.51	0.575	0.71		
K	1.20	1.35	1.50		
L	0.51	0.575	0.71		
L1	0.125 REF				
М	3.00	3.40 3.8			
θ	0 °	12			

GENERIC MARKING DIAGRAM*

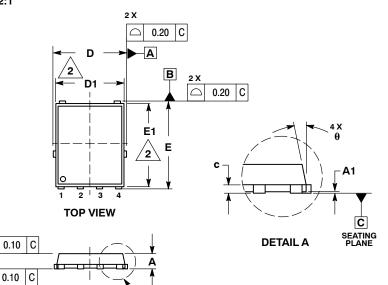


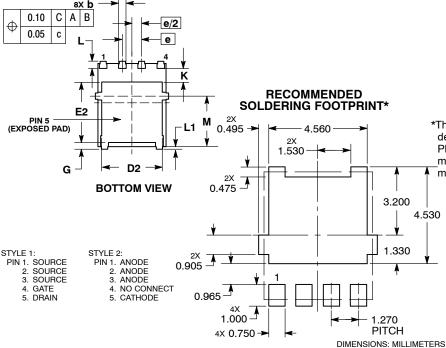
XXXXXX = Specific Device Code

= Assembly Location Α

Υ = Year W = Work Week ZZ = Lot Traceability

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





DETAIL A

*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

	DOCUMENT NUMBER:	98AON14036D	Electronic versions are uncontrolled except when accessed directly from the Document Repositor Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
ſ	DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1	

onsemi and ONSEMI. are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. **onsemi** makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does **onsemi** assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.

onsemi, Onsemi, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA class 3 medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase

ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:

 $\textbf{Technical Library:} \ \underline{www.onsemi.com/design/resources/technical-documentation}$

onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support

For additional information, please contact your local Sales Representative at

www.onsemi.com/support/sales

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

onsemi:

NTMFS4C06NT1G-001